

**Search Notes**

Application/Control No.

10/783,670

Examiner

Benjamin H. Layno

Applicant(s)/Patent under  
Reexamination

KO, SHENLI

Art Unit

3711

**SEARCHED**

| Class | Subclass         | Date     | Examiner |
|-------|------------------|----------|----------|
| 273   | 292, 274,<br>309 | 6/2/2005 | BHL      |
| 463   | 12, 13           |          |          |
|       |                  |          |          |
|       |                  |          |          |
|       |                  |          |          |
|       |                  |          |          |
|       |                  |          |          |
|       |                  |          |          |
|       |                  |          |          |
|       |                  |          |          |
|       |                  |          |          |
|       |                  |          |          |
|       |                  |          |          |
|       |                  |          |          |
|       |                  |          |          |
|       |                  |          |          |

**INTERFERENCE SEARCHED**

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|      | DATE     | EXMR |
|------|----------|------|
| East | 6/2/2005 | BHL  |
|      |          |      |
|      |          |      |
|      |          |      |
|      |          |      |
|      |          |      |
|      |          |      |
|      |          |      |
|      |          |      |
|      |          |      |
|      |          |      |
|      |          |      |
|      |          |      |
|      |          |      |
|      |          |      |
|      |          |      |
|      |          |      |